

**Notice of References Cited**

Application/Control No.

10/603,777

Applicant(s)/Patent Under

Reexamination

LEE ET AL.

Examiner

Laura S. Weiner

Art Unit

1745

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,162,178	11-1992	Ohsawa et al.	429/213
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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